

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13906-126001	Application No. 10/816,910
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Marcus Dill, et al.	
		Filing Date April 5, 2004	Group Art Unit 2171

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	2002/0144174	10/03/2002	Nwabueze			03/15/2001
EE	AB	2004/0210579	10/21/2004	Dettinger			04/17/2003
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
EE	AL	WO2003005232	01/16/2003	WIPO				
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
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	AU	

Examiner Signature /Emeka Ebirim/	Date Considered 10/18/2006
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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	Applicant		
	Filing Date <b>April 5, 2004</b>	Group Art Unit <b>Unknown</b>	

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	6,510,457	1/21/03	Ayukawa et al.			
EE	AB	6,460,037	10/1/02	Weiss et al.			
EE	AC	6,430,545	8/6/02	Honarvar et al.			
EE	AD	6,301,471	10/9/01	Dahm et al.			
EE	AE	6,272,478	8/7/01	Obata et al.			
EE	AF	6,266,668	7/24/01	Vanderveldt et al.			
EE	AG	6,173,310	1/9/01	Yost et al.			
EE	AH	6,049,599	4/11/00	McCausland et al.			
	AI						
	AJ						
	AK						

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	2002/0133490	09/19/2002	Conkwright,			12/18/2001
EE	AB	2004/0002961	01/01/2004	Dettinger,			06/27/2002
EE	AC	2004/0215501	10/28/2004	d'Ornano			04/24/2003
EE	AD	6,473,757	10/29/2002	Garofalakis			03/28/2000
EE	AE	6,636,860	10/21/2003	Vishnubhotla			04/26/2001
	AF						
	AG						
	AH						
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	AJ						
	AK						

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